



# Realization of Electrochemically Grown $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> Thin Films for Photoelectrochemical Water Splitting Application

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## Abstract

Hematite ferric oxide ( $\alpha$ -Fe<sub>2</sub>O<sub>3</sub>) based photoanode has emerged as a potential candidate for water splitting application due to its high absorption coefficient in the visible region and favorable band alignment. In the present work,  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> thin film photoanodes were fabricated using a cost-effective and straightforward electrodeposition technique. The crystal structure, phase purity, elemental composition, and formation of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> were confirmed by X-ray diffraction (XRD), photoluminescence (PL), X-ray photoelectron spectroscopy (XPS), Raman spectroscopy, energy-dispersive X-ray spectroscopy (EDS), and scanning electron microscopy (SEM). The band gap calculated from the absorption spectrum from UV-visible analysis of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> exhibited a significant absorption in the visible region. The  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> photoanodes were further characterized for their photoelectrochemical (PEC) properties along with electrochemical impedance spectroscopy (EIS) analysis. Furthermore, XRD, SEM, and Fourier transform infrared (FTIR) spectroscopy investigations were performed after photoelectrochemical measurement to ensure the stability of photoanodes. Also, the prepared photoanode was highly stable against a large range of pH conditions, and no photobleaching was observed for up to 30 min. Furthermore, a significant enhancement in the photocurrent conversion efficiency with an optimum film thickness was observed upon light illumination. A maximum photon conversion efficiency of 1.44 % was obtained with a photocurrent density of 6.25 mA/cm<sup>2</sup> for 1 V vs. saturated calomel electrode (SCE) under the simulated solar light.

**Keywords:**  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub>; Electrodeposition; Water Splitting; Photoelectrochemical; Photoanode; Stability; Solar Energy.

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## 1. Introduction

Gradually increasing demand for fossil fuels, residual carbon footprint, and adverse environmental impact have exerted enormous pressure on the already stretched world energy infrastructure. It is challenging to meet the ever-rising energy demand of growing economies due to the limited nature of fossil fuels. The emission of polluting gases such as CO<sub>2</sub>, CO, nitrogen oxides, sulfur dioxide, and other volatile organic compounds is significant. The improved standards of living and rapid industrialization have expedited the research in clean, eco-friendly, and low-cost energy harvesting

technologies. Among all possible alternative energy sources, solar water-splitting (H<sub>2</sub> and O<sub>2</sub> evolution) offers a great promise to fulfill the growing energy needs sustainably.<sup>[1]</sup> However, water splitting using semiconductor photoanodes requires a suitable bandgap, high chemical stability, and low kinetic overpotential. Moreover, appropriate band edge positions for H<sub>2</sub> and O<sub>2</sub> evolution and favorable charge transfer at the semiconductor/electrolyte interface play a crucial role in achieving high water splitting efficiencies.<sup>[2,3]</sup>

The phenomenon of solar hydrogen evolution *via* water splitting was first demonstrated using single-crystal titania (TiO<sub>2</sub>) as a photoanode with a bandgap of 3.2 eV by Fujishima and Honda in 1972.<sup>[4]</sup> However, the large bandgap (3.2 eV) limits its light absorption only in the ultra-violet (UV) region. Moreover, ZnO has been demonstrated as a prominent photoanode material with a bandgap similar to TiO<sub>2</sub> but has a much higher absorption coefficient (10<sup>4</sup>-10<sup>5</sup> cm<sup>-1</sup>) and a very high electron carrier mobility (~ 155 cm<sup>2</sup>s<sup>-1</sup>V<sup>-1</sup>).<sup>[5,6]</sup> However, the wide bandgap and inferior charge transport properties of

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these materials restrict their use in high-performance photoelectrochemical (PEC) applications. However, the narrow bandgap semiconductor materials such as CdS,<sup>[7]</sup> PbS,<sup>[8]</sup> CdSe,<sup>[9]</sup> Fe<sub>2</sub>O<sub>3</sub>,<sup>[10]</sup> Cu<sub>2</sub>SnS<sub>3</sub>,<sup>[11]</sup> and Cu<sub>2</sub>O<sup>[12]</sup> have been extensively explored for absorption in the visible region and to reduce the recombination of photo-generated charge carriers. Recently, ferric oxide (Fe<sub>2</sub>O<sub>3</sub>) has attracted significant consideration as a crucial photocatalytic material due to its narrow bandgap (~ 2.0 eV), high absorption coefficient (~ 10<sup>4</sup> cm<sup>-1</sup>), and suitable band edges.<sup>[13,14]</sup> Furthermore, it is inexpensive, naturally abundant, non-toxic, thermo-chemically stable in the aqueous environment, and has good environmental acceptability.<sup>[15,16]</sup> It has been explored for a variety of applications such as Li-ion batteries,<sup>[17,18]</sup> supercapacitors,<sup>[19]</sup> peroxide sensors,<sup>[20]</sup> solar energy conversion via water splitting,<sup>[21]</sup> dye degradation,<sup>[22]</sup> water purification, and treatment.<sup>[23,24]</sup> Thin films of Fe<sub>2</sub>O<sub>3</sub> have been prepared by various methods such as chemical vapor deposition,<sup>[25]</sup> sol-gel processes,<sup>[26]</sup> pulsed laser evaporation,<sup>[27]</sup> reactive sputtering,<sup>[28]</sup> hydrothermal method,<sup>[29]</sup> spray pyrolysis,<sup>[30,31]</sup> *etc.*

The pristine Fe<sub>2</sub>O<sub>3</sub> photoanodes have been studied for photocatalytic water splitting. However, a short excited-state lifetime<sup>[32-34]</sup> and a small hole diffusion length (2-20 nm)<sup>[35,36]</sup> restrict its commercial adaptations. The drawbacks can be overcome by using a suitable synthesis method to obtain Fe<sub>2</sub>O<sub>3</sub> thin films with excellent stability and thickness control to achieve minimum charge transfer resistance and reduce the recombination with rapid charge carrier collection. The maximum theoretical solar-to-hydrogen (STH) conversion efficiency at standard solar illumination for Fe<sub>2</sub>O<sub>3</sub> has been reported at ~ 15 %.<sup>[13,37]</sup> Even though significant progress in Fe<sub>2</sub>O<sub>3</sub> has been achieved, the performance improvement of various preparation strategies is still limited to committing 1-2 % efficiency so far. In this report, an attempt has been made to prepare stable and compact Fe<sub>2</sub>O<sub>3</sub> thin films by using a facile and inexpensive electrochemical deposition method that can withstand low applied potential and a wide range of pH conditions. Apart from preparing stable films, the potential cycle was varied as 10, 20, 30, and 40 cycles to achieve an optimum thickness. As a result, efficient Fe<sub>2</sub>O<sub>3</sub> photoanode films that can absorb most of the solar spectrum and benefit PEC water splitting can be obtained. As a result, we observed that the optical properties of Fe<sub>2</sub>O<sub>3</sub> films, namely band gap, band edge positions, and absorption of the prepared film, could be tuned just by varying potential cycles. Thus, the

maximum photon conversion efficiency of 1.44% corresponding to a photocurrent density of 6.25 mA/cm<sup>2</sup> at 1 V<sub>SCE</sub> for a film with 20 potential cycles has been observed. As per our knowledge, it is one of the best-reported photoresponses for α-Fe<sub>2</sub>O<sub>3</sub>-based PEC devices using the same electrodeposition technique. In addition to this, excellent stability of the prepared photoanode (scotch tape test) is achieved, which is further reconfirmed by XRD, FTIR, and SEM-EDS analysis after the electrochemical activity.

## 2. Experimental details

### 2.1 Chemicals

Ferric chloride (FeCl<sub>3</sub>), potassium fluoride (KF), potassium chloride (KCl), and hydrogen peroxide (H<sub>2</sub>O<sub>2</sub>) were used as received without any further purification.

### 2.2 Preparation of Fe<sub>2</sub>O<sub>3</sub> photoanode

The method employed for the thin film preparation of α-Fe<sub>2</sub>O<sub>3</sub> is the electrochemical deposition technique, which offers the facile synthesis route with control over film thickness vs. deposition cycle, low cost, uniform large-area deposition, and room temperature deposition. Moreover, the electrochemical deposition technique is a robust one, with no skilled labor required. The chemicals required for deposition are only cheap metal salts and water. Compared to other deposition techniques such as spin coating, doctor blade, chemical bath deposition (CBD), successive ionic layer adsorption and reaction (SILAR), sol-gel, spray pyrolysis, hydrothermal, *etc.*, the electrochemical deposition technique offers more advantages over others for the deposition of semiconductor junction thin films. Moreover, the electrodeposition technique helps conduct thin film deposition over a large area with good uniformity. For the synthesis of Fe<sub>2</sub>O<sub>3</sub> thin films, fluorine-doped tin oxide (FTO) coated glass substrates (2 cm × 1 cm) with a sheet resistance ~of 15 Ωcm<sup>-1</sup> and thickness ~of 150 nm were used. Firstly, the FTO-coated glass substrate was sequentially cleaned using acetone, ethanol, and distilled water in an ultrasonicator for 5 minutes each. Then, the chemical solution was prepared by using an aqueous electrolyte of 0.05 M FeCl<sub>3</sub>, 0.05 M KF, 0.1 M KCl, and 1 M H<sub>2</sub>O<sub>2</sub>. The electrochemical deposition was performed using an Autolab potentiostat (Model-N302) controlled in a three-electrode cell configuration system. FTO glass substrate, saturated calomel electrode (SCE), and Pt were used as working, reference, and counter electrodes. The thickness of Fe<sub>2</sub>O<sub>3</sub> thin films during electrodeposition is controlled by changing the number of deposition cycles.

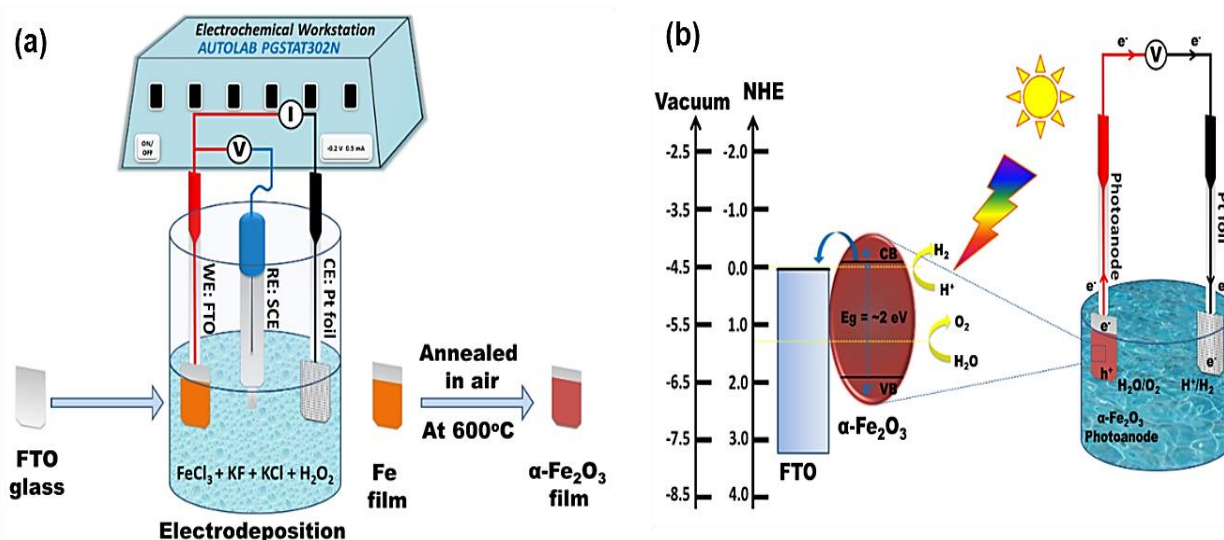
The Fe<sub>2</sub>O<sub>3</sub> thin films were deposited on the FTO substrate using the cyclic voltammetry with different potential cycles of 10, 20, 30, and 40 and were named Fe-10, Fe-20, Fe-30, and Fe-40, respectively. The potential during voltammetry was varied from -0.2 to 0 V (at a scan rate of 20 mV/s) at room temperature. The obtained films were annealed at 600 °C in an ambient atmosphere for 1 hr to obtain pure phase α-Fe<sub>2</sub>O<sub>3</sub> thin films. Fig. 1(a) shows the schematic of the

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**Fig. 1** Schematic representation (a) electrochemical deposition method employed to prepare  $\alpha$ - $\text{Fe}_2\text{O}_3$  thin films; and (b) PEC water splitting mechanism.

electrochemical deposition method for the preparation of  $\text{Fe}_2\text{O}_3$  thin films on the FTO substrate. The  $\text{Fe}_2\text{O}_3$  thin films deposited on an FTO glass were used as photoanode for PEC water splitting measurements in an aqueous electrolyte.

### 2.3 Material characterizations

XRD analysis of the prepared photoanodes was carried out using Bruker D8 Advance, Germany diffractometer equipped with a  $\text{Cu K}\alpha$  irradiation source ( $\lambda = 0.154 \text{ nm}$ ). Scanning electron microscopy (SEM) was used to analyze the samples' surface morphology using a JEOL JSM 6360A SEM equipped with energy-dispersive x-ray spectroscopy (EDS) with an operating voltage of 20 kV. The electronic absorption spectra were recorded using a JASCO V-670 UV-Visible spectrophotometer ranging from 450 to 700 nm to determine the bandgap and absorption band edges. Raman spectra were recorded with a Raman spectrophotometer (Horibra-Jobin Yvon LABRAM-HR) with a 532.8 nm He-Ne laser excitation source. The Raman laser power was kept at less than 5 mW to avoid laser-induced crystallization on the films. The steady-state photoluminescence (PL) spectra were recorded using Edinburgh Instruments FLS 980 spectrophotometer. The samples were excited using a 580-600 nm line for recording steady-state PL. The FTIR spectra were recorded in a transmission mode using an FTIR spectrophotometer (JASCO, 6100-type A) in the range  $550\text{-}4000 \text{ cm}^{-1}$ . The x-ray photoelectron spectra (XPS) were recorded using a Kratos Axis Ultra DLD photoelectron spectrometer instrument with a total energy resolution  $\sim$  of 0.9 eV fitted with an Al  $\text{K}\alpha$  radiation source (soft X-ray source at 1486.6 eV) at base vacuum  $>10^{-9}$  Torr. The XPS signal was obtained after several scans in the acquisition process. The spectra were recorded for the specific elements (Fe, O).

### 2.4 Photoelectrochemical study

Figure 1(b) illustrates the PEC water-splitting mechanism. The

PEC measurement was carried out in a standard three-electrode configuration with the  $\text{Fe}_2\text{O}_3$  photoanode as the working electrode, Pt plate as counter-electrode, and saturated calomel electrode (SCE) as reference electrode using a computer-controlled potentiostat (AUTO LAB PGSTAT302N, Metrohm make) equipped with a frequency response analyzer (FRA). An aqueous solution of 1 M NaOH was used as an electrolyte with a pH of 13. A solar simulator with a 150 W Xenon light source (PEC-L01) with an illumination intensity of  $100 \text{ mW/cm}^2$  was used to illuminate the surface of the photoanodes under light for current density-voltage (J-V), current density-time curves along with the electrochemical impedance spectroscopy (EIS) analysis. The impedance spectra were recorded under the light condition at 0.5 V vs. SCE applied potential with an alternating current (AC) modulation amplitude of 10 mV in the 0.1 Hz to 1 MHz frequency range. The J-V curves were measured with a 50 mV/s scan rate from -0.5 to 1.0 V vs. SCE.

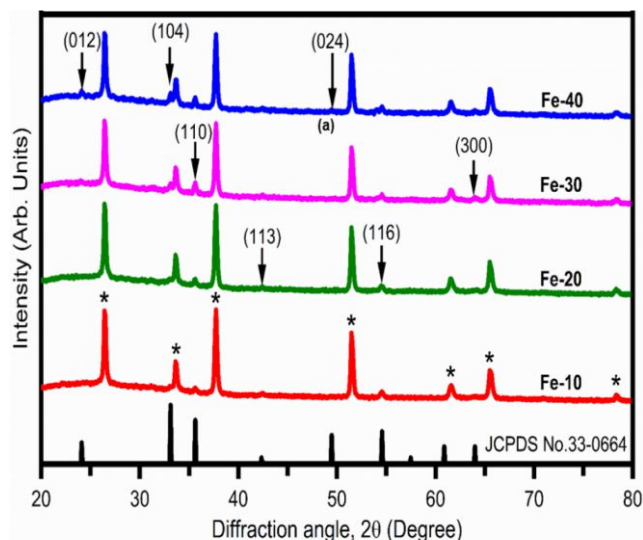
## 3. Results and discussion

### 3.1 X-ray diffraction (XRD) analysis

XRD measurements were carried out to understand the crystal phase and structure of as-deposited  $\text{Fe}_2\text{O}_3$  films. Fig. 2 shows the XRD pattern of the  $\text{Fe}_2\text{O}_3$  thin films deposited with 10, 20, 30, and 40 potential cycles, which are denoted by Fe-10, Fe-20, Fe-30, and Fe-40, respectively. The presence of multiple peaks in the XRD pattern points to the polycrystalline nature of  $\text{Fe}_2\text{O}_3$  films.

As seen from the XRD patterns, the prominent diffraction peaks were observed at  $2\theta \sim 24.2^\circ, 33.2^\circ, 35.5^\circ, 40.9^\circ, 49.46^\circ, 54.5^\circ$  and  $63.99^\circ$  corresponding to (012), (104), (110), (113), (024), (116) and (300) diffraction planes, respectively. These peaks show a good agreement with the hexagonal crystal structure of  $\alpha$ - $\text{Fe}_2\text{O}_3$  (JCPDS data file # 33-0664). The asterisk symbols (\*) represent the diffraction peaks obtained from the FTO substrate. It is clear from the XRD pattern that the

observed peaks correspond to the pure  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> phase without any secondary phases. Similar diffraction peaks were reported by Wei *et al.*<sup>[38]</sup> for Fe<sub>2</sub>O<sub>3</sub> films prepared by rapid thermal oxidation and by Wu *et al.*<sup>[39]</sup> for Fe<sub>2</sub>O<sub>3</sub> films prepared by microwave-assisted hydrothermal process. The lattice parameters (i.e.,  $a = 5.03$  Å and  $c = 13.7$  Å) show excellent agreement with the standard values reported for the  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> crystal structure.



**Fig. 2** XRD pattern of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> films deposited on FTO at different potential cycles in the electrochemical deposition method.

The crystallite size ( $d$ ) was calculated from the (110) peak using *Debye-Scherrer's* equation as shown in Equation (1):<sup>[40]</sup>

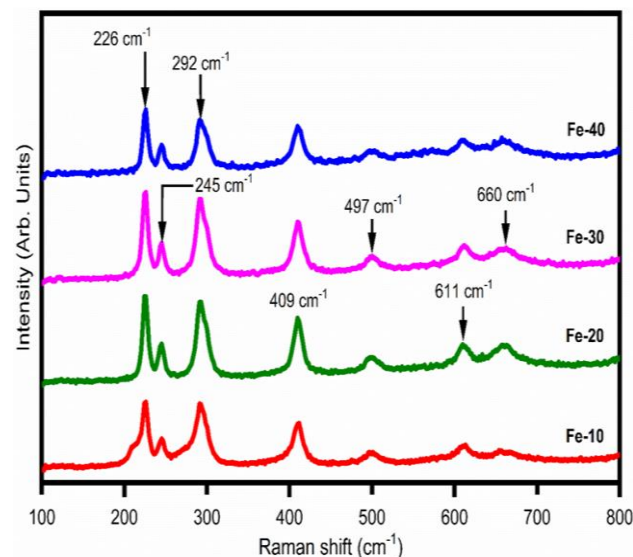
$$d = \frac{0.9\lambda}{\beta \cos\theta} \quad (1)$$

where  $\lambda$  is the x-ray source wavelength,  $\beta$  is the full width at half maximum (FWHM), and  $\theta$  represents Bragg's diffraction angle. The estimated average crystallite size is equal to  $\sim 29$  nm for the Fe-40 cycles sample. Although the  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> structure is observed for all the samples, a sample with fewer cycles (Fe-10) shows a relatively lower peak intensity due to low deposition. However, the phase formation and appearance of all the peaks are consistent for all the samples, which indicates that the potential cycles play an essential role in forming the crystalline phase of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub>.

### 3.2 Raman spectroscopy analysis

Raman spectroscopy is a robust characterization method used to detect various material phases based on discrete vibrational modes. Different phases of Fe<sub>2</sub>O<sub>3</sub> exhibit different characteristic phonon modes in Raman spectra, confirming the phase-type and purity of the material. The Raman vibrational spectra of Fe<sub>2</sub>O<sub>3</sub> films deposited on FTO at different potential cycles in the electrochemical deposition method in the range 100-800 cm<sup>-1</sup> are shown in Fig. 3. For all films, the Raman spectrum shows the major peaks at  $\sim 226$ , 245, 292, 409, 497, 611 and 660 cm<sup>-1</sup>. Raman peaks located at  $\sim 226$  and  $\sim 497$  cm<sup>-1</sup> correspond to the A<sub>1g</sub> mode, whereas all other peaks

located at  $\sim 245$ ,  $\sim 292$ ,  $\sim 409$ ,  $\sim 611$ , and  $\sim 660$  cm<sup>-1</sup> correspond to the E<sub>g</sub> mode of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub>. These results are in good agreement with the characteristic Raman spectrum of pristine  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> crystals with a hexagonal structure that displays two A<sub>1g</sub> and five E<sub>g</sub> phonon modes.<sup>[41,42]</sup> These findings confirm the high purity of the synthesized  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> as no other peaks for Fe<sub>2</sub>O<sub>3</sub> or oxyhydroxides are detected. The XRD results further validate this.

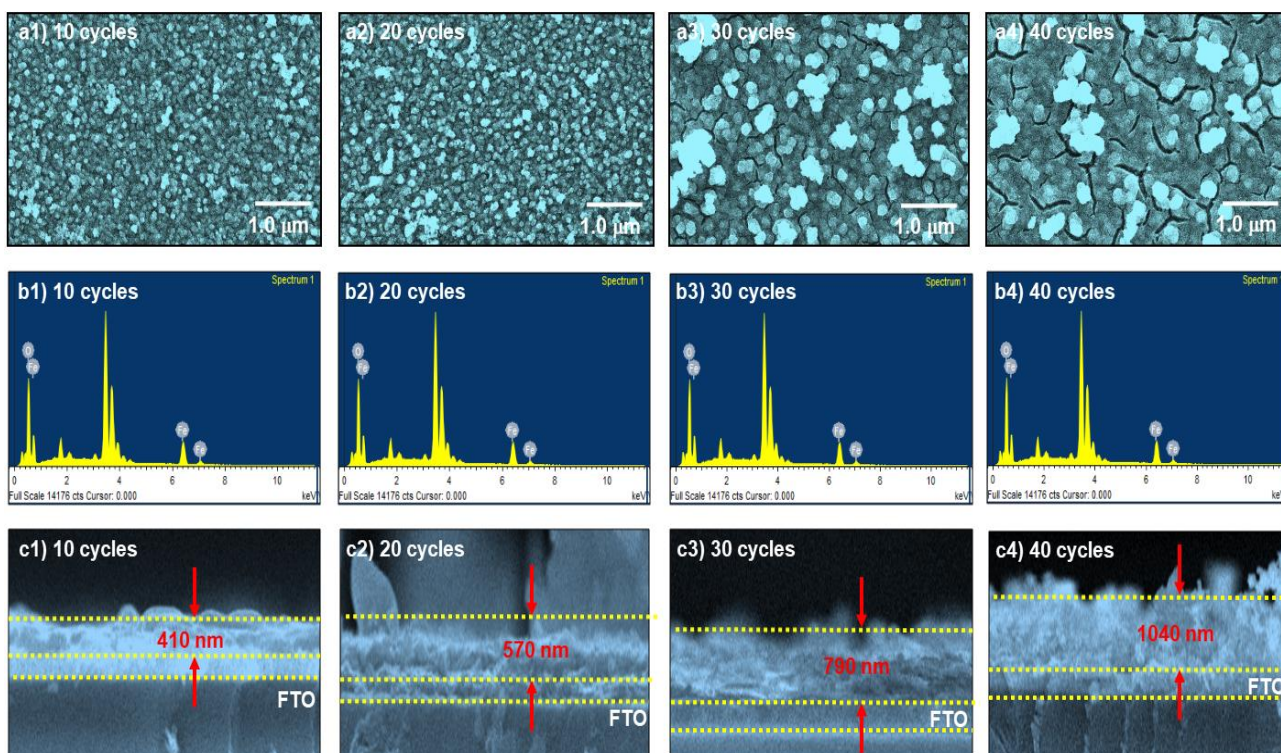


**Fig. 3** Raman spectra of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> films deposited at different potential cycles in the electrochemical deposition method.

### 3.3 Scanning electron microscopy analysis

The surface morphology of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> films is studied using SEM analysis. Figs. 4(a1) - (a4) shows the SEM micrographs of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> thin films deposited with 10, 20, 30, and 40 potential cycles. The  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> thin films deposited with 10 and 20 potential cycles (Figs. 4(a1) and (a2)) show granular morphology with uniform and dense growth of Fe<sub>2</sub>O<sub>3</sub> on FTO substrate with minor defects such as cracks, pinholes, and protrusions. However, the films deposited with higher deposition cycles such as 30 and 40 (Figs. 4(a3) and (a4)) demonstrate several notches on the film surface.

The appearance of cuts on the film surface may be due to the interfacial stress between Fe<sub>2</sub>O<sub>3</sub> and FTO substrate. The compositional analysis of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> films was carried out using the EDS technique. Figs. 4(b1) - (b4) shows the typical EDS spectra of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> films prepared with different potential cycles. These results indicate that Fe and O elemental composition is in the ratio  $\sim$ of 2:3 for all the films, which agrees with the stoichiometric ratio. Figs. 4(c1 - c4) shows the cross-sectional SEM images of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> films deposited by the electrochemical deposition method with various potential cycles. When the potential cycle during the electrodeposition process of samples Fe-10 to Fe-40 was increased from 10 to 40, the cross-sectional images of thin films indicate a linear change in thickness from 410 to 1040 nm, which agreed with the results reported by Zhou *et al.*<sup>[43]</sup>



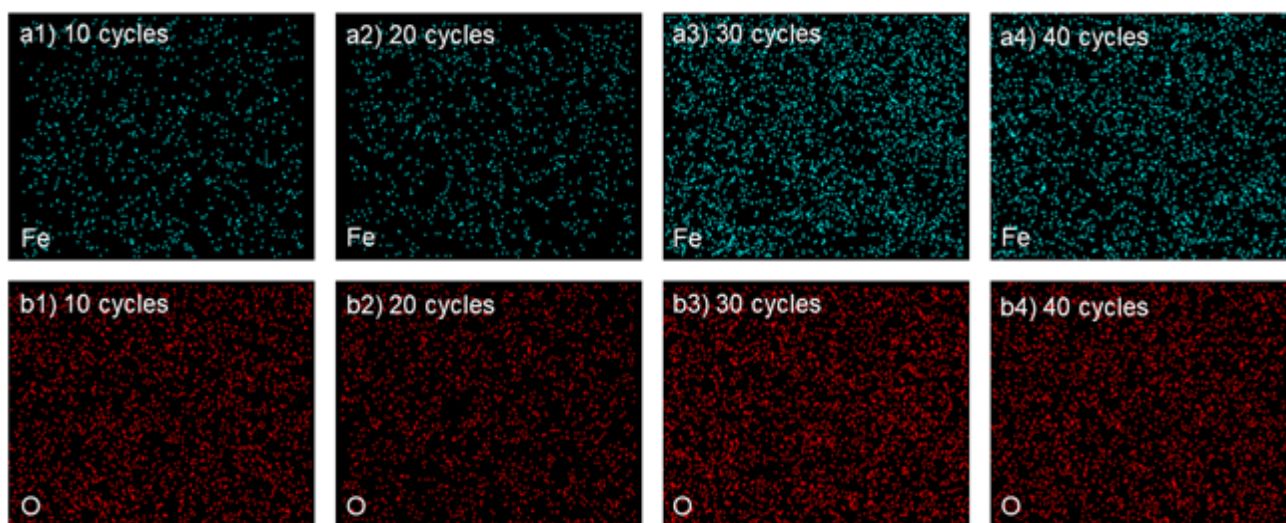
**Fig. 4** Top view SEM images (a1-a4), EDS spectra (b1-b4), and cross-sectional SEM images (c1-c4) of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> thin films deposited with potential cycles 10, 20, 30, and 40.

The EDS elemental mapping was carried out to analyze the elemental distribution of Fe and O in the Fe<sub>2</sub>O<sub>3</sub> thin films. The elemental mapping data reveals the uniform distribution of both elements. Figs. 5(a1) - (a4) and Fig. 5(b1) - (b4) show the EDAX elemental mapping for Fe and O elements, respectively. The observation suggests the stoichiometry of all film samples, which is in good agreement with the expected ratio (Fe:O  $\approx$  2:3).

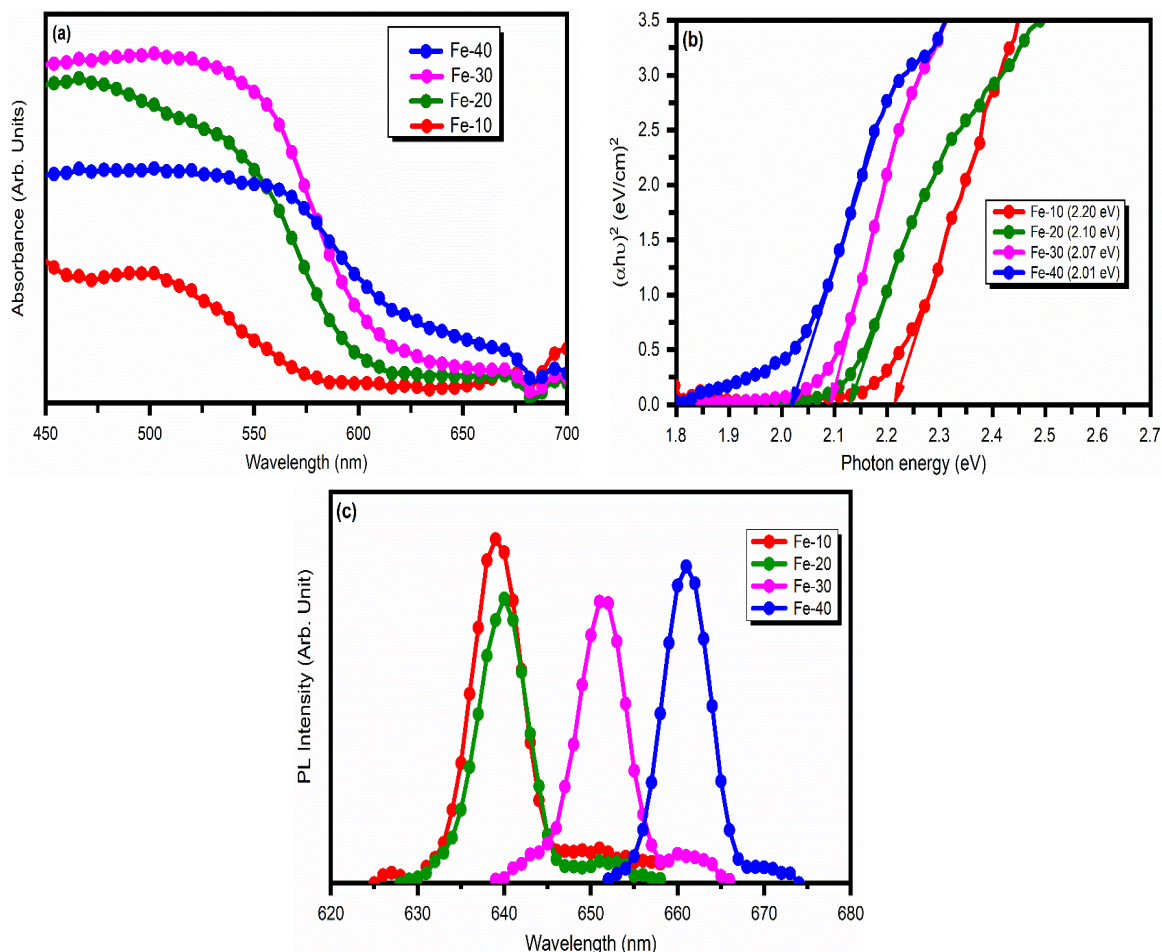
### 3.4 UV-Visible and PL spectroscopy analysis

The investigation of absorption properties of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> is very crucial for its PEC application. Therefore, the optical

properties of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> films, such as absorbance and band gap, were investigated using UV-Visible spectroscopy. Fig. 6(a) shows the UV-Visible absorption spectra of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> films deposited using the electrochemical deposition method at various potential cycles. The absorption edge in  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> films shifts towards a higher wavelength implying that  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> films absorb mainly in the visible region of the solar spectrum. The increment in the potential cycles of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> films leads to an absorption improvement, advantageous for PEC application. Furthermore, the absorbance plot indicates the direct band gap of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> films.



**Fig. 5** Elemental mapping of Fe and O for Fe-10 (a1 and b1), Fe-20 (a2 and b2), Fe-30 (a3 and b3), and Fe-40 (a4 and b4) samples, respectively.



**Fig. 6**  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> films deposited by the electrochemical deposition method with various potential cycles 10, 20, 30, and 40 (a) UV-Visible absorption spectra (b) Tauc plots, and (c) PL peak variation.

The energy-dependent absorption coefficient ( $\alpha$ ) can be expressed by the Equation (2):<sup>[44]</sup>

$$(\alpha h\nu)^{\frac{1}{\gamma}} = B(E - E_{opt}) \quad (2)$$

where  $h$  is the Planck constant,  $\nu$  is the photon's frequency,  $E_{opt}$  is the bandgap energy, and  $B$  is the state optical density. The  $\gamma$  factor depends on the nature of the transition and is equal to 1/2 or 2 for the direct and indirect transition bandgaps, respectively.<sup>[45]</sup> The absorption coefficient ( $\alpha$ ) can be found from the films' transmittance using Equation (3):<sup>[46]</sup>

$$\alpha = \frac{1}{d} \ln \left[ \frac{1}{T(\%)} \right] \quad (3)$$

where  $d$  and  $T$  are the thickness and transmittance of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> films, respectively.

The optical band gap is estimated from the Tauc plot, which is obtained by plotting photon energy ( $h\nu$ ) on the horizontal axis and  $(\alpha h\nu)^2$  on the vertical axis. The linear extrapolation of  $(\alpha h\nu)^2$  to the abscissa at zero permits the bandgap calculation. Fig. 6(b) shows the Tauc plots for  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> films deposited with various potential cycles. The band gap is decreased from 2.21 to 2.02 eV with increasing the potential cycle from 10 to 40. The reduction in the bandgap may be due to the increased  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> film thickness with an increase in potential cycles. It leads to good optical absorbance in the visible region and efficient separation of electron holes.

However, the recombination of charge carriers increases with an increase in the thickness of thin films. The optical bandgap values calculated from the present study agree with the recently reported bandgap values of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> films.<sup>[47,48]</sup>

The PL emission spectra of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> films (Fig. 6(c)) were obtained from PL spectroscopy, and the tuning of PL peak with varying potential cycles 10, 20, 30, and 40 was observed. Moreover, the PL spectra of these films show substantial apparent Stokes shifts and full widths at half maximum (FWHM). Furthermore, it is also observed that the peaks of the PL were gradually red-shifted from 639 to 661 nm as the potential cycle was increased from 10 to 40, which is attributed to the increased film thickness and consequently increased absorption of film. The obtained results are consistent with a similar trend of red shift in optical bandgap values as seen in UV-Visible analysis. All the obtained PL peaks (639 to 661 nm) are attributed to ligand field electronic transition  $6A_1 \rightarrow 4T_1(4G)$  of Fe<sup>3+</sup> exhibited in the condensed phase.<sup>[49,50]</sup> The lower value of emission intensity of Fe-20 than that of Fe-10, Fe-30, and Fe-40 illustrates that the recombination rate of electron holes in the case of Fe-20 is lower than that of other samples.<sup>[51]</sup> This leads to a higher photocatalytic activity of Fe-20 than all other samples, as observed in Fig. 8 (discussed later).

### 3.5 X-ray photoelectron spectroscopy (XPS) analysis

The XPS measurements were carried out to gain an insight into the oxidation states and surface chemical composition of  $\alpha$ - $\text{Fe}_2\text{O}_3$  thin films. Fig. 7(a) shows the typical XPS survey scan of  $\alpha$ - $\text{Fe}_2\text{O}_3$  films deposited by the electrochemical deposition method for 20 potential cycles. The spectra were excited by  $\text{Al } K_{\alpha}$  x-ray radiation (1486.6 eV) and calibrated against the C 1s line of carbon with the binding energy of 284.5 eV for hydrocarbon. The survey scan spectrum shows the iron (Fe 3p, Fe 3s, Fe 2p), carbon (C 1s), and oxygen (O 1s) peaks. The modes, in which most intense XPS lines occurred, were identified as elements 2p for Fe and 1s for O. These certain spectral lines were scanned with a high resolution (0.05 eV) to obtain details of the peak location and shapes in the region 700 to 740 eV for Fe 2p and 520 to 540 eV for O 1s. The peaks at 710.89 eV and 724.59 eV in the spectrum corresponding to the doublet of Fe  $2p_{3/2}$  and Fe  $2p_{1/2}$ , respectively, can be attributed to the formation of  $\text{Fe}_2\text{O}_3$ .<sup>[52]</sup> For Fe  $2p_{3/2}$  peaks, the major peak at 710.89 eV was attributed to Fe(III)-O, which corresponds to the  $\text{Fe}^{3+}$  chemical state. The C1s peak is usually present due to the adsorbed atmospheric hydrocarbons. Figs. 7(a) and fig. 7(b) shows the narrow scan for Fe 2p and O1s core-level x-ray photoelectron spectra of  $\text{Fe}_2\text{O}_3$  film. The deconvoluted peaks for O1s are depicted in Fig. 7(b), which shows the main peak at 529.8 eV, and the shoulder peak at 531.45 eV attributed to the lattice (denoted as  $\text{O}^{2-}$ ) and defect sites with low oxygen coordination, *i.e.*, oxygen vacancies on the sample surface. The core-level spectra of Fe display the x-ray photoelectron

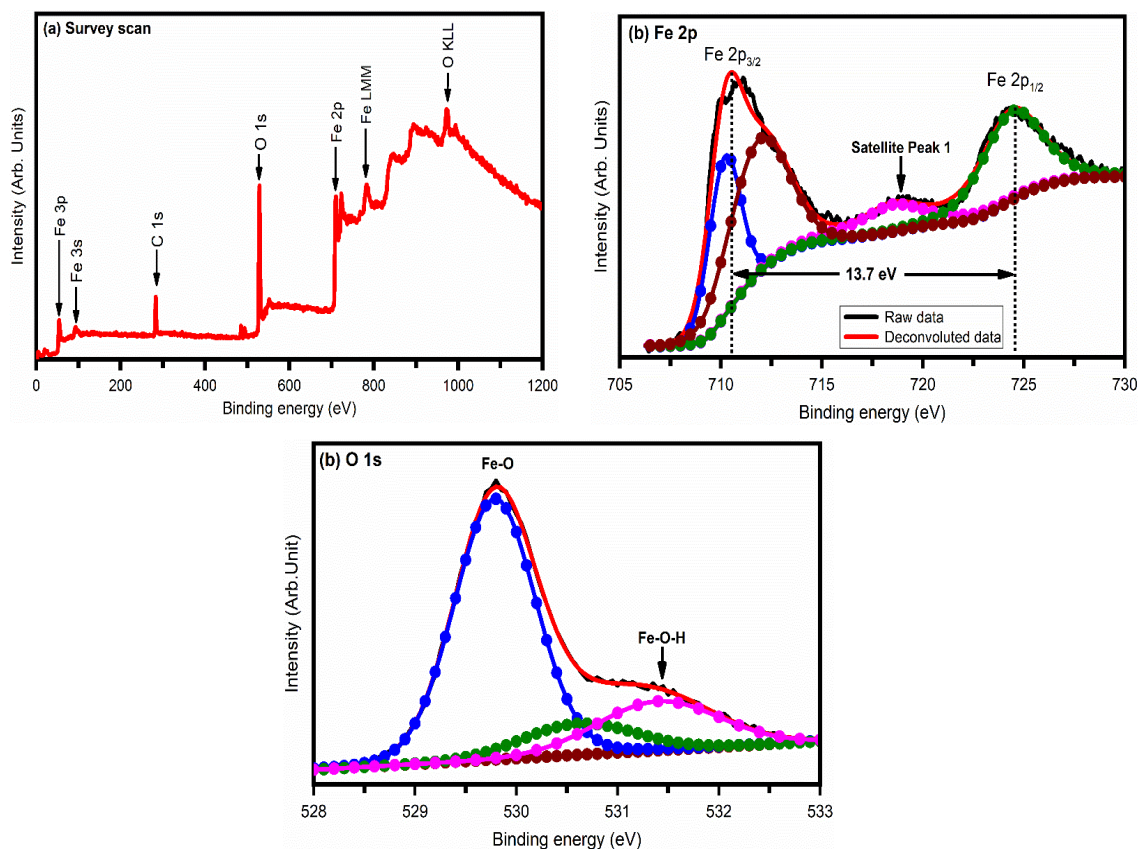
emission peaks for Fe  $2p_{3/2}$  and Fe  $2p_{1/2}$  at binding energies 710.89 and 724.59 eV, which are close to those of the standard values of  $\text{Fe}_2\text{O}_3$ . The characteristic spin-orbit splitting energy of 13.7 eV is clear evidence that Fe ions exist in the  $\text{Fe}^{3+}$  oxidation state of  $\text{Fe}_2\text{O}_3$ .<sup>[53]</sup> The elemental compositions of the films were calculated by Equation (4):

$$\% X = \frac{A_X/S_X}{\sum_{i=1}^N \frac{A_i}{S_i}} \quad (4)$$

where X is the element's name,  $A_X$  is the area under the peak of element X in the spectrum, and  $S_X$  is the sensitivity factor. For example, the sensitivity factors for iron  $2p_{3/2}$  and oxygen are 1.971 and 0.711 eV, respectively.<sup>[54,55]</sup> From the compositional analysis, it is revealed that the surface of the formed  $\text{Fe}_2\text{O}_3$  structure is oxygen deficient. The amount of oxygen is found to be ~ 73 % and that of Fe ~ 27 %. Thus, the composition calculated from XPS spectra for Fe:O is in good agreement. However, an excess amount of oxygen than Fe may be due to the adsorbed atmospheric oxygen at the surface of films.

### 3.6 Photoelectrochemical (PEC) measurements

The PEC measurements were carried out with the three-electrode system (Fig. 1), and the voltage varied from -0.6 to 0.6 V vs. SCE in a 1.0 M NaOH electrolyte. Fig. 8 shows the PEC activity of  $\alpha$ - $\text{Fe}_2\text{O}_3$  films photoanodes deposited using the electrochemical deposition method at various potential cycles. The PEC activity of the  $\alpha$ - $\text{Fe}_2\text{O}_3$  films



**Fig. 7** XPS analysis of  $\alpha$ - $\text{Fe}_2\text{O}_3$  films deposited by the electrochemical deposition method at 20 potential cycles (a) survey scan, (b) Fe 2P peak scan, and (c) O 1s with peaks related to Fe-O and Fe-OH bonds.

photoanode was evaluated using the linear sweep voltammetry (LSV). Fig. 8(a) shows the variation of photocurrent density (J) vs applied potential (V) for  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> films photoanodes deposited at various potential cycles. A minimal current of ~ 1  $\mu$ A/cm<sup>2</sup> was observed for  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> film photoanode during the measurement of current density in the dark because of a non-faradic reaction.

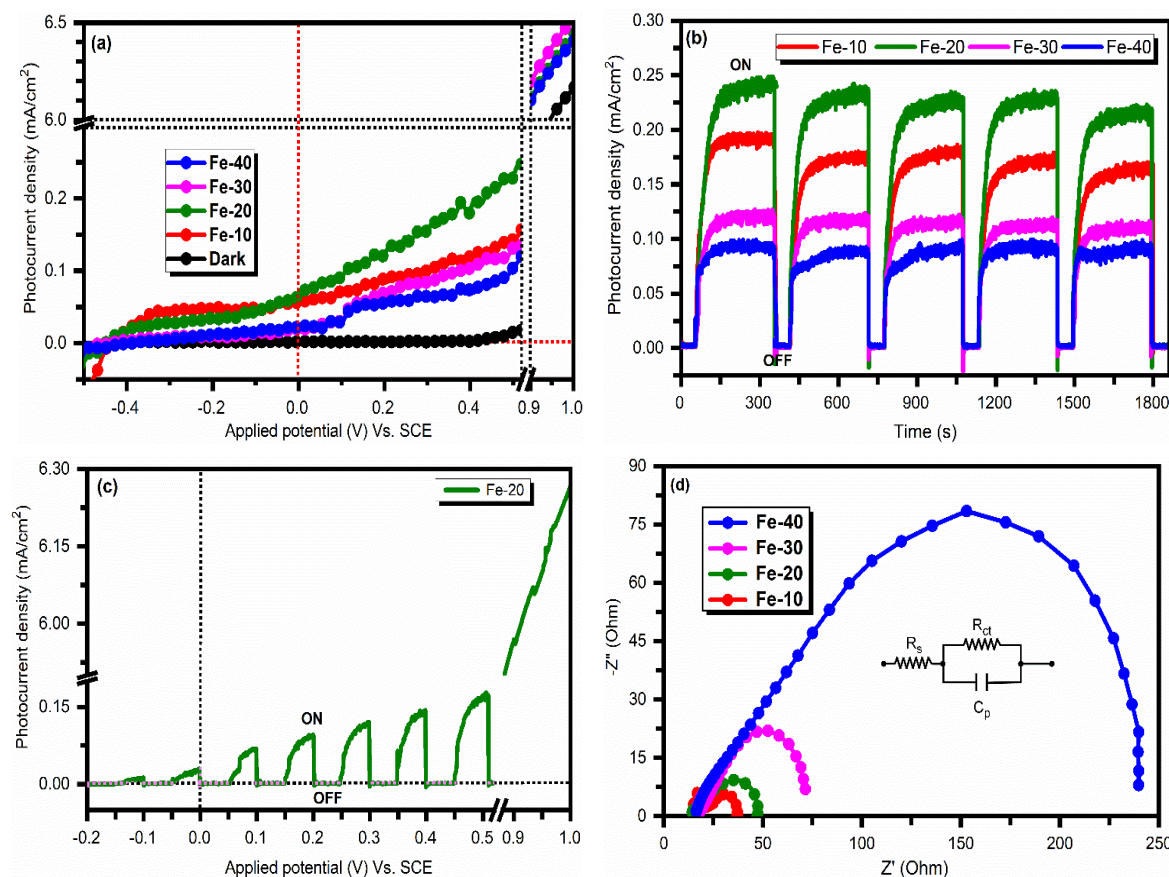
However, under illumination, the photocurrent density increases with an increase in applied potential and potential cycles. In addition, no photocurrent saturation is observed for the positive bias, indicating better charge separation upon illumination. Also, compared to Fe-10, Fe-30, and Fe-40 photoanode, Fe-20 photoanodes showed a significantly enhanced photocurrent, which can be attributed to the higher light absorption and the rapid transport of carrier of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> in the vicinity of electrolyte. It helps to harvest a large number of photons, leading to an increase in the number of charge carriers and thus an increase in photocurrent density. The high photocurrent density ~ 216  $\mu$ A/cm<sup>2</sup> is observed at a bias voltage of 0.5 V vs. SCE under 100 mW/cm<sup>2</sup> illumination for the Fe-20 sample, which is a good PEC performance.

Furthermore, the time-dependent light pulsed photocurrent response or chronoamperometric photocurrent density-time

profile (switching behavior) of the fabricated photoanodes was investigated at a bias potential of 0.5 V<sub>SCE</sub> as shown in Fig. 8(b). Chronoamperometry measurements were used to test the photoresponse and stability of photoanodes. From the chronoamperometric photocurrent response, it is observed that with an increase in potential cycles from 10 to 40, the corresponding photoresponses were improved. More specifically, a rise of photocurrent of ~ 190  $\mu$ A/cm<sup>2</sup>, 216  $\mu$ A/cm<sup>2</sup>, 122  $\mu$ A/cm<sup>2</sup> and 92  $\mu$ A/cm<sup>2</sup> at 0.5 vs SCE under light illumination as compared to the dark condition of photoresponse ~ 0  $\mu$ A/cm<sup>2</sup> were noticed for the photoanode film F-10, F-20, F-30 and F-40, respectively. The applied bias photon to current efficiency (ABPE) was calculated for  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> using Equation (5):

$$ABPE = \frac{J_{Ph} (1.23 - |V_{Bias}|)}{P_{Light}} \quad (5)$$

where J<sub>Ph</sub> is the photocurrent density (expressed in mA/cm<sup>2</sup>), V<sub>Bias</sub> is the applied external potential, and P<sub>Light</sub> is the light source illumination intensity.<sup>[56]</sup> A maximum photon conversion efficiency of 1.44 % is obtained at a bias voltage of 1 V vs. SCE at a photocurrent density of 6.25 mA/cm<sup>2</sup> for the Fe-20 sample. The results are further supported by EIS analysis.



**Fig. 8** (a) Photocurrent density (J) vs applied potential (V) of photoanodes obtained  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> films deposited by the electrochemical deposition method with various potential cycles, (b) chronoamperometric photocurrent density (J) – time (t) profile (switching behavior) of photoanodes obtained from  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> films deposited by the electrochemical deposition method with various potential cycles with chopped light at 0.5 V vs. SCE. (c) chopped LSV of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> films deposited by the electrochemical deposition method at 20 potential cycles, and (d) Nyquist plots of the  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> electrode deposited using the electrochemical deposition method at various potential cycles.

To understand the improved PEC performance mechanism, the electrochemical kinetics, the charge transport, and transfer dynamics of the  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> photoanodes operated in 1 M NaOH electrolyte were also studied with EIS in a frequency range of 0.1 Hz to 100 kHz at a bias of 0.5 V vs. SCE under sunlight irradiation. Fig. 8(d) shows the Nyquist plots of the  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> electrode obtained from the EIS measurements. The Fe-10 and Fe-20 samples show a smaller impedance than Fe-30 and Fe-40 samples. Even though the impedance of Fe-10 is smaller than Fe-20, it also exhibits a higher recombination loss across the Fe-10 sample and electrolyte. The fitted equivalent electrical circuit is shown in the inset of Fig. 8(d). The fitted model consists of series resistance ( $R_s$ ), interfacial charge transfer resistance ( $R_{ct}$ ), the bulk capacitance of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> ( $C_{bulk}$ ), and the capacitance of the space charge layer at the interface Fe<sub>2</sub>O<sub>3</sub>/electrolyte ( $C_{sc}$ ).

**Table 1.** EIS analysis for  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> thin films prepared at different potential cycles.

Potential cycles	V <sub>b</sub> (Volt)	R <sub>s</sub> (Ohm)	R <sub>ct</sub> (Ohm)
10	0.5	15	16
20	0.5	14	27
30	0.5	18	51
40	0.5	16	221

The Nyquist plot is a useful way to illustrate the semiconductor/electrolyte interfacial charge transfer process and the junction properties. The Nyquist plot arc radius represents the electron transfer resistance reflecting the electrode reaction energy barrier, and thus a decreased semicircle radii reflect a decrease in charge transfer resistance.<sup>[57]</sup> Resistance quantification analysis is shown in Fig. 8(d), indicating that all the photoanodes have a lower semicircle diameter (see Table 1). The lowest equivalent series resistance ( $R_s$ ) obtained for all samples is ~ 14-18  $\Omega$ . As seen in Table 1, the charge transfer resistance ( $R_{ct}$ ) value varies from a minimum value of 16  $\Omega$  for the Fe-10 sample to 221  $\Omega$  for the Fe-40 sample. All the synthesized samples show a considerable reduction in interfacial resistance between electrode and electrolyte, improving charge transfer efficiency. It may be due to the absorption of light and electron-hole pairs separation away from the interface. The incident photon creates an electron-hole pair upon absorption by photoanode as the electron moves from the valence band into the conduction band with a hole left behind in the valence band. The electron moves through the outer circuit to the counter electrode surface (Pt) and reduces the absorbed H<sup>+</sup> ions to produce H<sub>2</sub>. The holes oxidize the OH<sup>-</sup> ions that evolve oxygen at the semiconductor-electrolyte interface.<sup>[58]</sup> Due to much higher notches/cracks on the Fe-40 sample surface as observed in SEM, the photo-generated charge carriers cannot reach the FTO surface, eventually hinder the carrier transport and thus reducing the photocurrent.

Our prepared photoanode is highly stable on the device

level even after a long time (30 min) of light irradiation (photostable). The fabricated photoanode has passed the scotch tape test *i.e.*, good adhesive films. The comparison of our PEC performance result with the already reported values is shown in Table 2, along with various methods used to prepare hierarchical nanostructured  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> photoanodes. It is found that various methods have been used for the preparation of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> photoanodes and the electrodeposition method was the most frequently used method, as indicated in Table 2. As per our knowledge, it has been observed that the electrodeposited  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> film showed the photoresponse with photocurrent density values in the range from the lowest 0.12 mA/cm<sup>2</sup> at 0.6 V<sub>SCE</sub> to the highest 1.35 mA/cm<sup>2</sup> at 1.23 V<sub>SCE</sub>.<sup>[43,59]</sup> In contrast, we have achieved the photocurrent density of 0.216 mA/cm<sup>2</sup> at 0.5 V<sub>SCE</sub> or 6.25 mA/cm<sup>2</sup> at 1 V<sub>SCE</sub> biased potential (Fig. 8(a)) with spherical morphology.

In comparing our observed photoresponse with the various preparation methods and morphologies, our results are much better while looking at the overall cost of the photoanode, which is evident from Table 2. Moreover, various composite photoanodes have been tried, namely, Au- $\alpha$ -Fe<sub>2</sub>O<sub>3</sub>, IOS- $\alpha$ -Fe<sub>2</sub>O<sub>3</sub>, and Au/Zr-Fe<sub>2</sub>O<sub>3</sub>/Au achieved photoresponses in a range of 1.30 to 8 mA/cm<sup>2</sup>.<sup>[43,60,61]</sup> In comparison with the overall development in  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub>-based photoanodes, our results will encourage researchers to develop further 'Au' based composite photoanodes as reported by Mao *et al.*, where they reported the highest photocurrent density to date of 8 mA/cm<sup>2</sup> at 0.6 V using the same technique.<sup>[60]</sup>

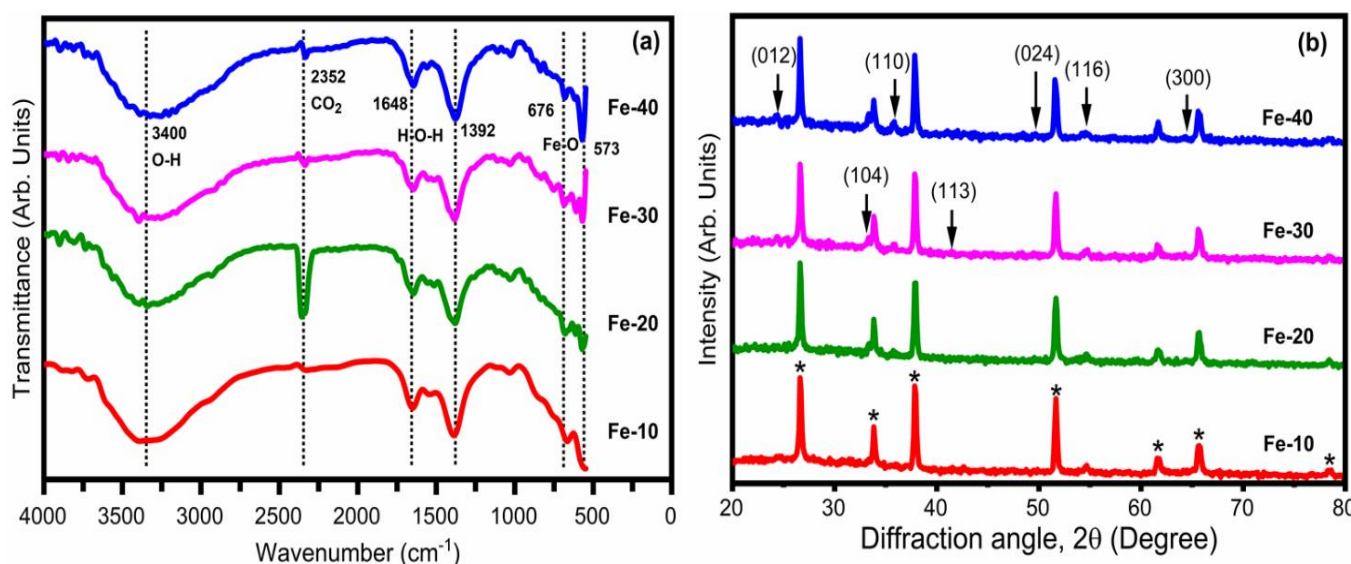
### 3.7 Sample stability analysis

To ensure the stability of the samples after electrochemical measurement, we have further studied all samples via various characteristics using FTIR and XRD by Figs. 9(a-b). To ensure the structural and morphological stability of the samples after electrochemical measurement, the PEC-measured photoanode films were further investigated by FTIR and XRD, as shown in Figs. 9(a) and (b), respectively. The bonding configurations of the deposited thin films after photoelectrochemical measurements were investigated by the Fourier transform infrared (FTIR) spectroscopy. The FTIR spectra of the synthesized Fe<sub>2</sub>O<sub>3</sub> thin films in the range of 550- 4000 cm<sup>-1</sup> are shown in Fig 9(a). The broad bands observed between 3600-3000 cm<sup>-1</sup> centered at ~ 3400 cm<sup>-1</sup> are linked to the stretching O-H vibration of intermolecular and intramolecular hydrogen bonds in hydroxyl (OH<sup>-</sup>) groups of the physically adsorbed water molecules after electrochemical analysis. The peaks ~ 1648 and ~ 1381 cm<sup>-1</sup> are due to the H-O-H's asymmetric and symmetric bending vibration. The peak at 2352 cm<sup>-1</sup> is related to atmospheric CO<sub>2</sub>. The appearance of two well-defined peaks at 573 and 676 cm<sup>-1</sup> is attributed to the Fe-O lattice vibrations in the stretching mode of the hematite phase of Fe<sub>2</sub>O<sub>3</sub>.<sup>[62-65]</sup> Furthermore, no significant changes in intensity and peak position of all samples were noticed in the XRD pattern of all films after PEC measurements. Also, the surface morphology and compactness of all films observed

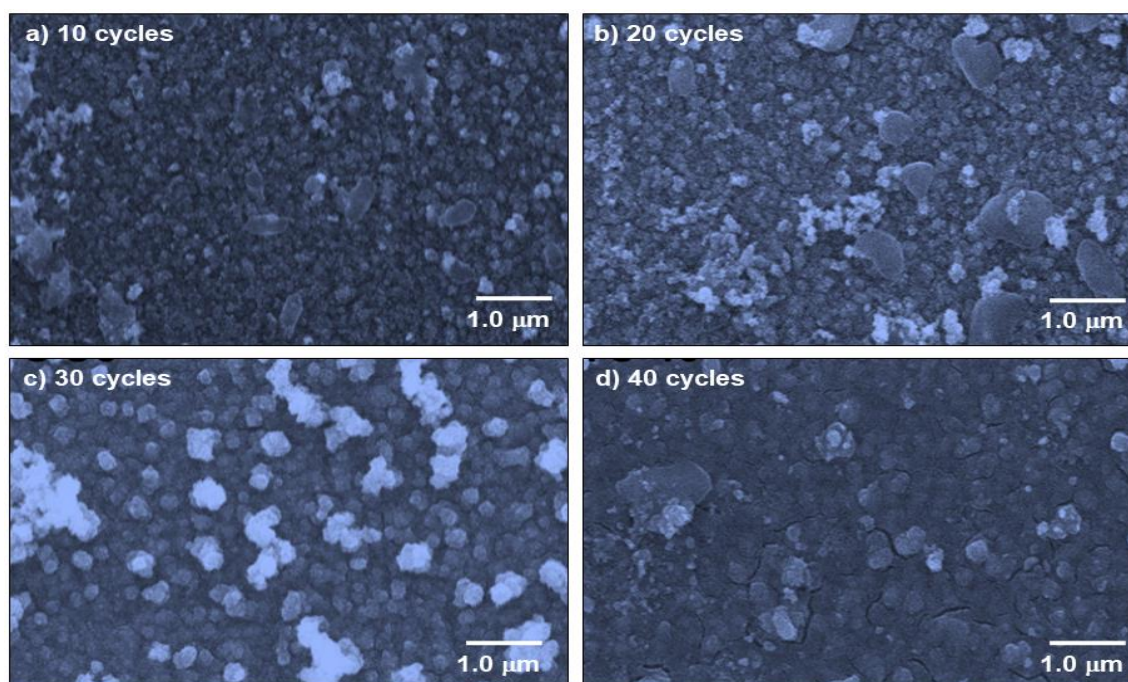
through SEM images were found to be unchanged [Figs. 10 measurement on the quality of prepared film using (a)-(d)]. Hence, there is no significant effect of PEC electrodeposition.

**Table 2.** Comparison of PEC performance of hierarchical nanostructured  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> photoanodes prepared by various methods.

Material	Morphology	Synthesis method	Electrolyte	PEC performance	Ref.
$\alpha$ -Fe <sub>2</sub> O <sub>3</sub>	Worm-like	Sol-Gel method	0.1 M Na <sub>2</sub> SO <sub>4</sub>	11 $\mu$ A/cm <sup>2</sup> at 0.57 V <sub>Ag/AgCl</sub>	[32]
$\alpha$ -Fe <sub>2</sub> O <sub>3</sub>	Particles structure	Pulsed plasma	0.1 M Na <sub>2</sub> SO <sub>4</sub>	186.7 $\mu$ A/cm <sup>2</sup> at 0.57 V <sub>Ag/AgCl</sub>	[32]
$\alpha$ -Fe <sub>2</sub> O <sub>3</sub>	Nanoparticles	Electrodeposition	1M KOH	1.35 mA/cm <sup>2</sup> at 1.23 V	[43]
Au/Zr-Fe <sub>2</sub> O <sub>3</sub> /Au	Spherical particle	Electrodeposition	1 M NaOH	1.30 mA/cm <sup>2</sup>	[43]
$\alpha$ -Fe <sub>2</sub> O <sub>3</sub>	Granule in nature	Electrodeposition	1 M NaOH	0.12 mA/cm <sup>2</sup> At 0.6 V/SCE	[59]
Au- $\alpha$ -Fe <sub>2</sub> O <sub>3</sub>	nanorods	Electrodeposition	1 M NaOH	8 mA/cm <sup>2</sup> At 0.6V vs Ag/AgCl	[60]
IOS- $\alpha$ -Fe <sub>2</sub> O <sub>3</sub>	Nanoparticles	Electrodeposition	1 M NaOH	3.1 mA/cm <sup>2</sup> 0.5 V Ag/AgCl	[61]
$\alpha$ -Fe <sub>2</sub> O <sub>3</sub>	Islands of Particles	Electrodeposition	1 M NaOH	390 $\mu$ A/cm <sup>2</sup> at 0.4 V <sub>Ag/AgCl</sub>	[66]
$\alpha$ -Fe <sub>2</sub> O <sub>3</sub>	nano pedals	Pulse reverse electrodeposition	1 M NaOH	0.75 mA/cm <sup>2</sup> 0.65 V Ag/AgCl	[67]
$\alpha$ -Fe <sub>2</sub> O <sub>3</sub>	Nanoflakes	AACVD	0.5 M Na <sub>2</sub> SO <sub>4</sub> 0.1 M Na <sub>2</sub> SO <sub>3</sub>	585 uA/cm <sup>2</sup> Ag/AgCl at 1.23 V	[68]
$\alpha$ -Fe <sub>2</sub> O <sub>3</sub>	Nanoparticle	Electrodeposition	1 M NaOH	257.08 uA Ag/AgCl at 1.23 V	[69]
$\alpha$ -Fe <sub>2</sub> O <sub>3</sub>	Nanorods	Hydrothermal	1 M KOH	0.45 mA/cm <sup>2</sup> Ag/AgCl at 1.23V	[70]
$\alpha$ -Fe <sub>2</sub> O <sub>3</sub>	Agglomerated	Pulse reverse electrodeposition	1 M NaOH	504 uA/cm <sup>2</sup> 1.23 V <sub>RHE</sub>	[71]
$\alpha$ -Fe <sub>2</sub> O <sub>3</sub>	Mesoporous nature	Hydrothermal-electrodeposition	1M NaOH	43.7uA/cm <sup>2</sup>	[72]
$\alpha$ -Fe <sub>2</sub> O <sub>3</sub>	Nanoparticles	Thermal decomposition	1M NaOH	3 mA/cm <sup>2</sup> At 1.23 V <sub>RHE</sub>	[73]
$\alpha$ -Fe <sub>2</sub> O <sub>3</sub>	Spherical particles	Electrodeposition	1 M NaOH	216 $\mu$ A/cm <sup>2</sup> at 0.5 V <sub>SCE</sub> and 6.25 mA/cm <sup>2</sup> at 1 V <sub>SCE</sub>	Present Work



**Fig. 9**  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> films deposited on FTO at different potential cycles in the electrochemical deposition method after PEC measurement (a) FTIR spectra (b) XRD pattern.



**Fig. 10** (a-d) SEM images of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> electrodes after PEC measurements.

The present photocatalytic system offers a facile and straightforward water-splitting cell development technique, although it suffers from the poor separation of charge carriers and surfaces back reaction. Furthermore, the combination of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> with wide band gaps in nano-structured semiconductors like ZnO and TiO<sub>2</sub> can further improve the water-splitting performance.

#### 4. Conclusions

The hematite-Fe<sub>2</sub>O<sub>3</sub> ( $\alpha$ -Fe<sub>2</sub>O<sub>3</sub>) thin-film photoelectrodes were synthesized using a facile and cost-effective electrodeposition technique with various potential cycles corresponding to different thicknesses of deposited films. The as-prepared  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> thin films have been characterized by XRD and Raman spectroscopy, which confirm the formation of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub>. SEM analysis showed that the  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> thin films deposited with 10 and 20 potential cycles revealed dense and uniform growth with granular morphology of Fe<sub>2</sub>O<sub>3</sub> on the FTO surface with very few defects. However, the deposited films with more deposition cycles showed notches on the film surface. The elemental composition analysis of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> films performed using the EDS, and XPS analysis showed that the Fe and O elemental compositions are close to the stoichiometric ratio 2:3 in all films and with the Fe<sup>3+</sup> and O<sup>2-</sup> chemical states. UV-visible spectroscopy shows that  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> absorbs mainly in the visible region, and the bandgap decreases from 2.21 to 2.02 eV with an increase in potential cycles from 10 to 40. PEC and EIS measurements were used to evaluate the suitability of  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> thin films for photoanode. A maximum photon conversion efficiency of 1.44% was obtained with a photocurrent density of 6.25 mA/cm<sup>2</sup> at 1 V vs. SCE under simulated solar light. The prepared photoanode was highly stable against all pH conditions, and no photobleaching was

observed for up to 30 min with the stability analysis. We believe that combining  $\alpha$ -Fe<sub>2</sub>O<sub>3</sub> with wide band gap nano-structured semiconductors like ZnO, and Ti O<sub>2</sub> can further improve the solar water splitting performance.

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#### Conflict of interest

There are no conflicts to declare.

#### Supporting information

Not applicable.

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